DISCRETE SEMICONDUCTORS

DATA SHEET

BF410A to DN-channel silicon field-effect transistors

Product specification
File under Discrete Semiconductors, SC07

December 1990





N-channel silicon field-effect transistors

BF410A to D

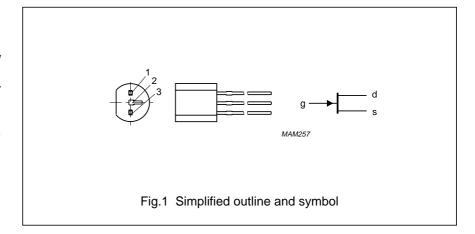
DESCRIPTION

Asymmetrical N-channel planar epitaxial junction field-effect transistors in a plastic TO-92 variant; intended for applications up to the VHF range.

These FETs can be supplied in four I_{DSS} groups. Special features are the low feedback capacitance and the low noise figure. Thanks to these special features the BF410 is very suitable for applications such as the RF stages in FM portables (type A), car radios (type B) and mains radios (type C) or the mixer stage (type D).

PINNING - TO-92 VARIANT

1 = drain2 = source3 = gate



QUICK REFERENCE DATA

Drain-source voltage	V _{DS}	max.			20		V
Drain current (DC or average)	I_{D}	max.		30			mA
Total power dissipation							
up to T _{amb} = 75 °C	P_{tot}	max.		3	00		mW
		BF4	10A	В	С	D	
Drain current							-
$V_{DS} = 10 \text{ V}; V_{GS} = 0$		min.	0.7	2.5	6	10	mA
	I _{DSS}	max.	3.0	7.0	12	18	mA
Transfer admittance							
$V_{DS} = 10 \text{ V}; V_{GS} = 0; f = 1 \text{ kHz}$	y _{fs}	min.	2.5	4	6	7	mS
Feedback capacitance							
$V_{DS} = 10 \text{ V}; V_{GS} = 0$	C_{rs}	typ.	0.5	0.5	_	_	pF
$V_{DS} = 10 \text{ V}; I_D = 5 \text{ mA}$	C_{rs}	typ.	_	_	0.5	0.5	pF
Noise figure at optimum source admittance							
$G_S = 1 \text{ mS}; -B_S = 3 \text{ mS}; f = 100 \text{ MHz}$							
$V_{DS} = 10 \text{ V}; V_{GS} = 0$	F	typ.	1.5	1.5	_	_	dB
$V_{DS} = 10 \text{ V}; I_D = 5 \text{ mA}$	F	typ.	_	_	1.5	1.5	dB

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RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Drain-source voltage	V_{DS}	max.	20	V
Drain-gate voltage (open source)	V_{DGO}	max.	20	V
Drain current (DC or average)	I_{D}	max.	30	mΑ
Gate current	\pmI_G	max.	10	mΑ
Total power dissipation up to T _{amb} = 75 °C	P_{tot}	max.	300	mW
Storage temperature range	T_{stg}	–65 to −	+150	°C
Junction temperature	T _i	max.	150	°С

THERMAL RESISTANCE

From junction to ambient in free air

 $R_{th j-a}$ = 250 K/W

STATIC CHARACTERISTICS

 $T_{amb} = 25 \, ^{\circ}C$

Gate cut-off current			BF410A	В	С	D	
$-V_{GS} = 0.2 \text{ V}; V_{DS} = 0$	-I _{GSS}	max.	10	10	10	10	nA
Gate-drain breakdown voltage							
$I_S = 0$; $-I_D = 10 \mu A$	$-V_{(BR)GDO}$	min.	20	20	20	20	V
Drain current							
$V_{DS} = 10 \text{ V}; V_{GS} = 0$		min.	0.7	2.5	6	10	mΑ
	I _{DSS}	max.	3.0	7.0	12	18	mΑ
Gate-source cut-off voltage							
$I_D = 10 \mu A; V_{DS} = 10 V$	$-V_{(P)GS}$	typ.	0.8	1.5	2.2	3	V

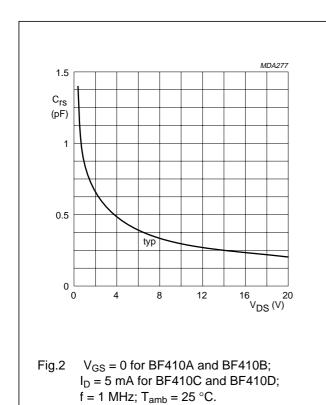
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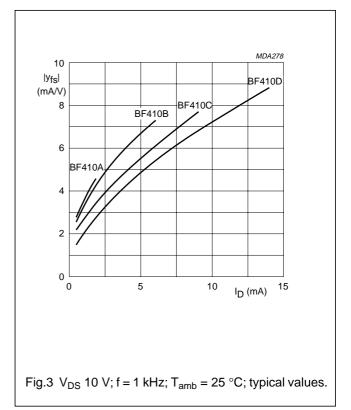
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DYNAMIC CHARACTERISTICS

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y-parameters (common source)			BF410A	В	С	D	
Input capacitance at f = 1 MHz	C_{is}	max.	5	5	5	5	рF
Input conductance at f = 100 MHz	g _{is}	typ.	100	90	60	50	μS
Feedback capacitance at f = 1 MHz	C_{rs}	typ.	0.5	0.5	0.5	0.5	pF
r ceuback capacitance at r = 1 Wir iz	Ors	max.	0.7	0.7	0.7	0.7	pF
Transfer admittance at f = 1 kHz	$ y_{fs} $	min.	2.5	4.0	4.0	3.5	mS
$V_{GS} = 0$ instead of $I_D = 5$ mA	$ y_{fs} $	min.	_	_	6.0	7.0	mS
Transfer admittance at f = 100 MHz	$ y_{fs} $	typ.	3.5	5.5	5.0	5.0	mS
Output capacitance at f = 1 MHz	C_{os}	max.	3	3	3	3	рF
Output conductance at f = 1 MHz	gos	max.	60	80	100	120	μS
Output conductance at f = 100 MHz	g _{os}	typ.	35	55	70	90	μS
Noise figure at optimum source admittance							
$G_S = 1 \text{ mS}$; $-B_S = 3 \text{ mS}$; $f = 100 \text{ MHz}$	F	typ.	1.5	1.5	1.5	1.5	dB





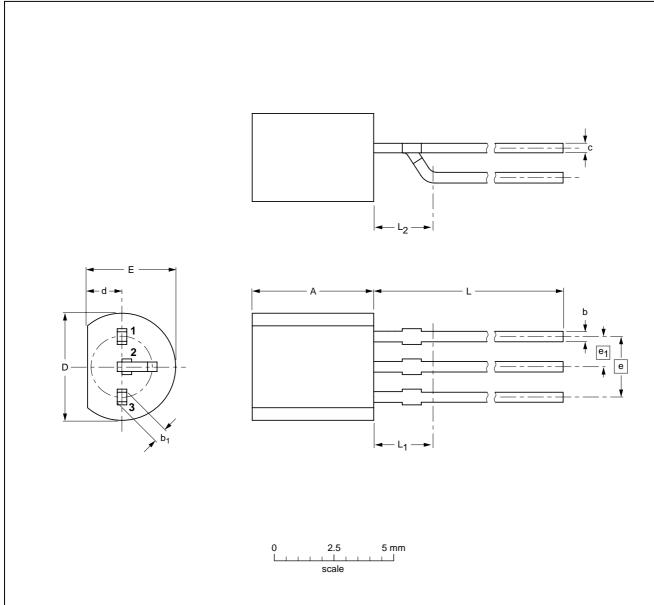
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PACKAGE OUTLINE

Plastic single-ended leaded (through hole) package; 3 leads (on-circle)

SOT54 variant



DIMENSIONS (mm are the original dimensions)

UNIT	Α	b	b ₁	С	D	d	E	е	e ₁	L	L ₁ ⁽¹⁾ max	L ₂ max
mm	5.2 5.0	0.48 0.40	0.66 0.56	0.45 0.40	4.8 4.4	1.7 1.4	4.2 3.6	2.54	1.27	14.5 12.7	2.5	2.5

Notes

1. Terminal dimensions within this zone are uncontrolled to allow for flow of plastic and terminal irregularities.

OUTLINE		REFER	RENCES		EUROPEAN ISSUE DATE			EUROPEAN	
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE			
SOT54 variant		TO-92	SC-43			97-04-14			

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DEFINITIONS

Data sheet status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Short-form specification	The data in this specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.
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Limiting values

Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information

Where application information is given, it is advisory and does not form part of the specification.

LIFE SUPPORT APPLICATIONS

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